## Notice of References Cited Application/Control No. 10/664,509 Examiner TAN X. DINH Applicant(s)/Patent Under Reexamination KONDO ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*	,	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-4,725,502	02-1988	Kiyomiya et al.	369/288
*	В	US-4,310,919	01-1982	Slaten, Gary G.	369/275.5
*	С	US-4,800,112	01-1989	Kano et al.	428/163
*	D	US-5,059,473	10-1991	Takahashi et al.	369/275.1
*	E	US-5,828,648 A	10-1998	Takasu et al.	369/275.1
*	F	US-5,770,348 A	06-1998	Kondo, Tetsuya	369/275.1
	G	US-			
	Н	US-			
	1	US-			
-	j -	US-			
	К	US-			
	L	US-			••
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## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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## NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)								
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	W									
	х	(C. MOED 8 707 05(A))								

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.